

|                                   |                                       |   |             |
|-----------------------------------|---------------------------------------|---|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>10/661,535 | Applicant(s)/Patent Under<br>Reexamination<br>HIRAKAWA ET AL. |             |
|                                   | Examiner<br>Stephen G. Sherman        | Art Unit<br>2674  | Page 1 of 1 |

**U.S. PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name             | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-2002/0191008                                  | 12-2002         | Naka et al.      | 345/690        |
| * | B | US-2001/0054993                                  | 12-2001         | Kanazawa et al.  | 345/60         |
| * | C | US-2003/0011540                                  | 01-2003         | Tokunaga et al.  | 345/60         |
| * | D | US-2003/0067425                                  | 04-2003         | Tokunaga et al.  | 345/60         |
| * | E | US-2003/0098826                                  | 05-2003         | Moon, Seong Hak  | 345/75.2       |
| * | F | US-2001/0017605                                  | 08-2001         | Hashimoto et al. | 345/60         |
| * | G | US-2003/0011542                                  | 01-2003         | Nakamura, Hideto | 345/63         |
| * | H | US-2003/0189534                                  | 10-2003         | Myoung et al.    | 345/67         |
|   | I | US-  |                 |                  |                |
|   | J | US-  |                 |                  |                |
|   | K | US-  |                 |                  |                |
|   | L | US-  |                 |                  |                |
|   | M | US-  |                 |                  |                |

**FOREIGN PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name            | Classification |
|---|---|--|-----------------|---------|-----------------|----------------|
|   | N | JP 2000148085 A                                  | 05-2000         | Japan   | AWAJI, NORIYUKI | G09G 03/28     |
|   | O | JP 2000276106 A                                  | 10-2000         | Japan   | TOKUNAGA et al. | G09G 03/28     |
|   | P |  |                 |         |                 |                |
|   | Q |  |                 |         |                 |                |
|   | R |  |                 |         |                 |                |
|   | S |  |                 |         |                 |                |
|   | T |  |                 |         |                 |                |

**NON-PATENT DOCUMENTS**

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
|   | U |   |
|   | V |   |
|   | W |   |
|   | X |   |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.